Application/Control No. Applicant(s)/Patent Under Reexamination 10/550,836 YUMIKI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Michael A. Strieb 2809 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-US-В С US-D US-US-Е US-F US-G US-Н US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 2001-182722 06-2001 Japan Mitsuhusa et al Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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